


<b>Search Notes</b>  	<b>Application/Control No.</b>  10540671	<b>Applicant(s)/Patent Under Reexamination</b>  CHANG, CHIN
	<b>Examiner</b>  Haissa Philogene	<b>Art Unit</b>  2821

SEARCHED			
Class	Subclass	Date	Examiner
327	91, 94, 96, 108, 109	6/17/08	Philogene
323	282, 259	6/17/08	Philogene
315	291, 224, 312	6/17/08	Philogene

SEARCH NOTES		
Search Notes	Date	Examiner

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
327	94, 108, 109	6/17/08	Philogene
315	291	6/17/08	Philogene
323	282	6/17/08	Philogene